

**Notice of References Cited**

Application/Control No.

09/156,276

Applicant(s)/Patent Under  
Reexamination  
SACHDEVA ET AL.

Examiner

Cris L. Rodriguez

Art Unit

3763

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,311,858	05-1994	Adair, Edwin L.	600/106
	B	US-6,168,603	01-2001	Leslie et al.	606/114
	C	US-5,846,248	12-1998	Chu et al.	606/113
	D	US-5,496,330	03-1996	Bates et al.	606/113
	E	US-5,190,557	03-1993	Borodulin et al.	604/22
	F	US-4,625,726	12-1986	Duthoy, Everette J.	606/127
	G	US-5,397,320	03-1995	Essig et al.	606/110
	H	US-5,957,900	09-1999	Ouchi, Teruo	600/104
	I	US-5,064,428	11-1991	Cope et al.	606/127
	J	US-5,643,313	07-1997	Levin, John M.	604/264
	K	US-5,160,342	11-1992	Reger et al.	606/159
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.